

Search Notes

Application/Control No.

10/527,220

Examiner

Patricia T. Nguyen

Applicant(s)/Patent under
Reexamination

HAYASE, HIROMICHI

Art Unit

2817

SEARCHED

Class	Subclass	Date	Examiner
330	149	5/7/2007	PN
	297		
	107		

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST		